

ROUTINE AND SUPPLEMENTARY TESTS
OF SUBSCRIBER SENDERS1. GENERAL

- 1.1 This temporary instruction is issued to provide an operational test for mutilated digit registration when Options ZL or ZM are furnished in Subscriber Sender Circuit, SD-27810-01.

2. INSTRUCTION

- 2.1 Add to Handbook 61, Section 162.1, Paragraph 5.

5.2 Mutilated Digit Peg Count5.21 Option ZL Furnished

- 5.211 Make-busy any SD-27810-01 sender. In any convenient manner, apply ground to contact 4 of relay CS.

- 5.212 At the Originating Sender Test Frame, SD-25221-01, verify key CTR is operated for the selected sender and make a test call which does not require the use of a 4 to form the C digit. Verify that registers SS and MTD each score once and lamp S lights to agree with selected sender.

- 5.213 Remove ground, release sender, and restore test frame to normal.

5.22 Option ZM Furnished

- 5.221 Make busy any SD-27810-01 sender. In any convenient manner, apply ground to contact 4 of relay CS.

- 5.222 At the Originating Sender Test Frame, SD-25221-01, verify key CTR is operated for the selected sender and make a test call which does not require the use of a 4 to form the C digit. Verify that the MTD register is scored once and lamp S for the sender under test does not light.

- 5.223 Remove ground, release sender, and restore test frame to normal.

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